CD54HC4051, CD74HC4051
CD54HCT4051, CD74HCT4051, CD54HC4052, CD74HC4052, CD54HCT4052
CD74HCT4052, CD54HC4053, CD74HC4053, CD54HCT4053, CD74HCT4053
SCHS122L – NOVEMBER 1997 – REVISED FEBRUARY 2017

CDx4HC405x, CDx4HCT405x High-Speed CMOS Logic Analog Multiplexers and Demultiplexers

1 Features

- Wide Analog Input Voltage Range: ±5-V Maximum
- Low ON-Resistance
  - 7-Ω Typical (V_{CC} – V_{EE} = 4.5 V)
  - 40-Ω Typical (V_{CC} – V_{EE} = 9 V)
- Low Crosstalk Between Switches
- Fast Switching and Propagation Speeds
- Break-Before-Make Switching
- Wide Operating Temperature Range: –55°C to +125°C
- CD54HC and CD74HC Types
  - Operation Control Voltage: 2 V to 6 V
  - Switch Voltage: 0 V to 10 V
- CD54HCT and CD74HCT Types
  - Operation Control Voltage: 4.5 V to 5.5 V
  - Switch Voltage: 0 V to 10 V
  - Direct LSTTL Input Logic Compatibility V_{IL} = 0.8-V Max, V_{IH} = 2-V Min
  - CMOS Input Compatibility $I_I \leq 1$ µA at V_{OL}, V_{OH}
- On Products Compliant to MIL-PRF-38535, All Parameters Are Tested Unless Otherwise Noted. On All Other Products, Production Processing Does Not Necessarily Include Testing of All Parameters.

2 Applications

- Digital Radio
- Signal Gating
- Factory Automation
- Televisions
- Appliances
- Programmable Logic Circuits
- Sensors

3 Description

The CDx4HC405x and CDx4HCT405x devices are digitally controlled analog switches that use silicon gate CMOS technology to achieve operating speeds similar to LSTTL with the low-power consumption of standard CMOS integrated circuits.

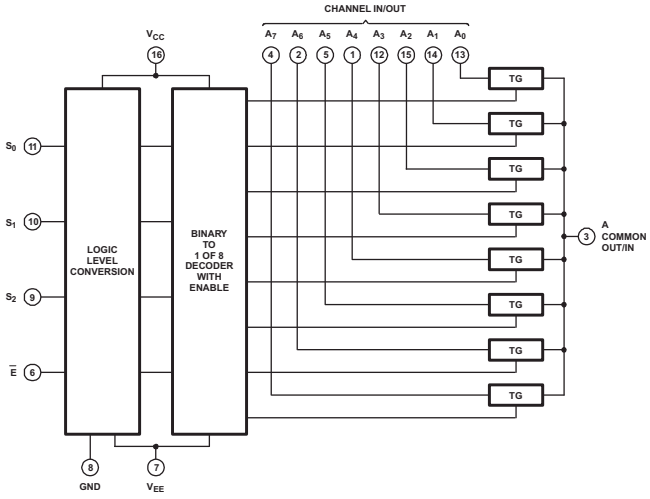
These analog multiplexers and demultiplexers control analog voltages that may vary across the voltage supply range (for example, V_{CC} to V_{EE}). They are bidirectional switches that allow any analog input to be used as an output and vice versa. The switches have low ON resistance and low OFF leakages. In addition, all these devices have an enable control that, when high, disables all switches to their OFF state.

Device Information[1]

PART NUMBER	PACKAGE	BODY SIZE (NOM)
CD54HCx405xF	CDIP (16)	19.56 mm × 6.92 mm
CD74HCx405xE	PDIP (16)	19.30 mm × 6.35 mm
CD74HCx405xM	SOIC (16)	9.90 mm × 3.91 mm
CD74HCx405xNS	SOP (16)	10.30 mm × 5.30 mm
CD74HCx405xPW	TSSOP (16)	5.00 mm × 4.40 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Functional Diagram of HC4051 and HCT4051



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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision K (September 2015) to Revision L — **Page**

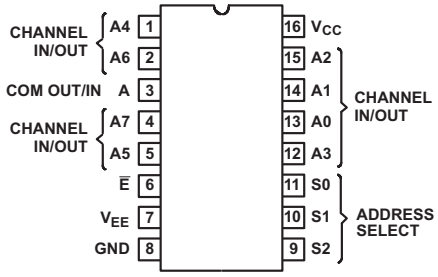
- Changed Charged device model (CDM) value from: ±1000 V to: ±200 V ... 6
- Added *Receiving Notification of Documentation Updates* section ... 26

Changes from Revision J (February 2011) to Revision K — **Page**

- Removed *Ordering Information* table. ... 1
- Added *Device Information* table, *Pin Functions* table, *ESD Ratings* table, *Thermal Information* table, *Detailed Description* section, *Applications and Implementation* section, *Power Supply Recommendations* section, *Layout* section, *Device and Documentation Support* section, and *Mechanical, Packaging, and Orderable Information* section ... 1
- Added Military Disclaimer to *Features* list. ... 1

5 Pin Configuration and Functions

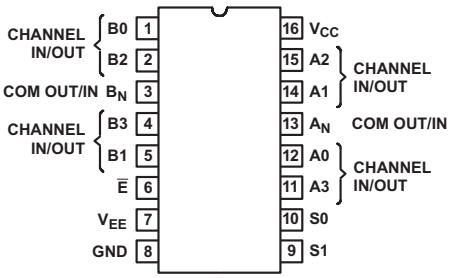
CD54HC4051, CD54HCT4051, CD74HC4051, CD74HCT4051 J, N, D, NS, PW Packages
16-Pin CDIP, PDIP, SOIC, SO, TSSOP
Top View



Pin Functions for CDx4HCx4051B

PIN		I/O	DESCRIPTION
NO.	NAME		
1	CH A4 IN/OUT	I/O	Channel 4 in/out
2	CH A6 IN/OUT	I/O	Channel 6 in/out
3	COM OUT/IN	I/O	Common out/in
4	CH A7 IN/OUT	I/O	Channel 7 in/out
5	CH A5 IN/OUT	I/O	Channel 5 in/out
6	$\overline{E}$	I	Enable Channels (Active Low). See Table 1.
7	V_{EE}	—	Negative power input
8	GND	—	Ground
9	S2	I	Channel select 2. See Table 1.
10	S1	I	Channel select 1. See Table 1.
11	S0	I	Channel select 0. See Table 1.
12	CH A3 IN/OUT	I/O	Channel 3 in/out
13	CH A0 IN/OUT	I/O	Channel 0 in/out
14	CH A1 IN/OUT	I/O	Channel 1 in/out
15	CH A2 IN/OUT	I/O	Channel 2 in/out
16	V_{CC}	—	Positive power input

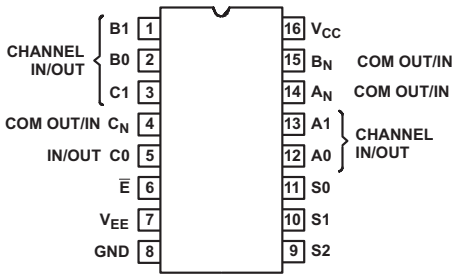
CD54HC4052, CD74HC4052, CD74HCT4052 J, N, D, NS, PW Packages
16-Pin CDIP, PDIP, SOIC, SO, TSSOP
Top View



Pin Functions for CDx4HCx4052B

PIN		I/O	DESCRIPTION
NO.	NAME		
1	CH B0 IN/OUT	I/O	Channel B0 in/out
2	CH B2 IN/OUT	I/O	Channel B2 in/out
3	COM B OUT/IN	I/O	B common out/in
4	CH B3 IN/OUT	I/O	Channel B3 in/out
5	CH B1 IN/OUT	I/O	Channel B1 in/out
6	$\overline{E}$	I	Enable channels (Active Low). See Table 2.
7	V_{EE}	—	Negative power input
8	GND	—	Ground
9	S1	I	Channel select 1. See Table 2.
10	S0	I	Channel select 0. See Table 2.
11	CH A3 IN/OUT	I/O	Channel A3 in/out
12	CH A0 IN/OUT	I/O	Channel A0 in/out
13	COM A IN/OUT	I/O	A common out/in
14	CH A1 IN/OUT	I/O	Channel A1 in/out
15	CH A2 IN/OUT	I/O	Channel A2 in/out
16	V_{CC}	—	Positive power input

CD54HC4053 CD74HC4053 CD74HCT4053 J, N, D, NS, PW Packages
16-Pin CDIP, PDIP, SOIC, SOP, TSSOP
TOP VIEW



Pin Functions CDx4HCx4053B

PIN		I/O	DESCRIPTION
NO.	NAME		
1	B1 IN/OUT	I/O	B channel Y in/out
2	B0 IN/OUT	I/O	B channel X in/out
3	C1 IN/OUT	I/O	C channel Y in/out
4	COM C OUT/IN	I/O	C common out/in
5	C0 IN/OUT	I/O	C channel X in/out
6	$\overline{E}$	I	Enable channels (Active Low). See Table 3.
7	V_{EE}	—	Negative power input
8	GND	—	Ground
9	S2	I	Channel select 2. See Table 3.
10	S1	I	Channel select 1. See Table 3.
11	S0	I	Channel select 0. See Table 3.
12	A0 IN/OUT	I/O	A channel X in/out
13	A1 IN/OUT	I/O	A channel Y in/out
14	COM A OUT/IN	I/O	A common out/in
15	COM B OUT/IN	I/O	B common out/in
16	V_{CC}	—	Positive power input

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
$V_{CC} - V_{EE}$	DC supply voltage		–0.5	10.5	V
V_{CC}	DC supply voltage		–0.5	7	V
V_{EE}	DC supply voltage		0.5	–7	V
I_{IK}	DC input diode current	$V_I < -0.5$ V or $V_I > V_{CC} + 0.5$ V		±20	mA
I_{OK}	DC switch diode current	$V_I < V_{EE} - 0.5$ V or $V_I > V_{CC} + 0.5$ V		±20	mA
	DC switch current(2)	$V_I > V_{EE} - 0.5$ V or $V_I < V_{CC} + 0.5$ V		±25	mA
I_{CC}	DC V_{CC} or ground current			±50	mA
I_{EE}	DC V_{EE} current			–20	mA
T_{JMAX}	Maximum junction temperature			150	°C
T_{LMAX}	Maximum lead temperature	Soldering 10 s		300	°C
T_J	Junction temperature			150	°C
T_{stg}	Storage temperature		–65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
(2) All voltages referenced to GND unless otherwise specified.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001(1)	±500	V
		Charged device model (CDM), per JEDEC specification JESD22-C101(2)	±200	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage range (T_A = full package temperature range)(2)	CD54 and 74HC types	2		6	V
		CD54 and 74HCT types	4.5		5.5	
$V_{CC} - V_{EE}$	Supply voltage range (T_A = full package temperature range)	CD54 and 74HC types, CD54 and 74HCT types (see Figure 1)	2		10	V
V_{EE}	Supply voltage range (T_A = full package temperature range)(3)	CD54 and 74HC types, CD54 and 74HCT types (see Figure 2)	0		–6	V
V_I	DC input control voltage		GND		V_{CC}	V
V_{IS}	Analog switch I/O voltage		V_{EE}		V_{CC}	V
T_A	Operating temperature		–55		125	°C
t_r, t_f	Input rise and fall times	2 V	0		1000	ns
		4.5 V	0		500	
		6 V	0		400	

(1) For maximum reliability, nominal operating conditions must be selected so that operation is always within the ranges specified in the *Recommended Operating Conditions* table.
(2) All voltages referenced to GND unless otherwise specified.
(3) In certain applications, the external load resistor current may include both V_{CC} and signal line components. To avoid drawing V_{CC} current when switch current flows into the transmission gate inputs, the voltage drop across the bidirectional switch must not exceed 0.6 V (calculated from r_{ON} values shown in *Electrical Characteristics: HC Devices* and *Electrical Characteristics: HCT Devices* tables). No V_{CC} current will flow through R_L if the switch current flows into terminal 3 on the HC and HCT4051; terminals 3 and 13 on the HC and HCT4052; terminals 4, 14, and 15 on the HC and HCT4053.

6.4 Thermal Information

THERMAL METRIC[1]		CD74HC4051			UNIT
		N (PDIP)	NS (SO)	PW (TSSOP)	
		16 PINS	16 PINS	16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	49.0	83.0	107.7	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	36.3	41.2	42.4	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	29.0	43.3	52.8	°C/W
ψ_{JT}	Junction-to-top characterization parameter	21.2	9.2	4.2	°C/W
ψ_{JB}	Junction-to-board characterization parameter	28.9	43.0	52.2	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.

6.5 Electrical Characteristics: HC Devices

PARAMETERS		TEST CONDITIONS					MIN	TYP	MAX	UNIT
		V_{IS} (V)	V_I (V)	V_{EE} (V)	V_{CC} (V)	T_A				
V_{IH}	High-level input voltage				2	25°C	1.5			V
						–40°C to +85°C	1.5			
						–55°C to +125°C	1.5			
					4.5	25°C	3.15			
						–40°C to +85°C	3.15			
						–55°C to +125°C	3.15			
					6	25°C	4.2			
						–40°C to +85°C	4.2			
						–55°C to +125°C	4.2			
V_{IL}	Low-level input voltage				2	25°C			0.5	V
						–40°C to +85°C			0.5	
						–55°C to +125°C			0.5	
					4.5	25°C			1.35	
						–40°C to +85°C			1.35	
						–55°C to +125°C			1.35	
					6	25°C			1.8	
						–40°C to +85°C			1.8	
						–55°C to +125°C			1.8	

Electrical Characteristics: HC Devices (continued)

PARAMETERS			TEST CONDITIONS					MIN	TYP	MAX	UNIT
			V_{IS} (V)	V_I (V)	V_{EE} (V)	V_{CC} (V)	T_A				
r_{ON}	ON resistance	I_O = 1 mA See Figure 21	V_{CC} or V_{EE}	V_{IL} or V_{IH}	0	4.5	25°C		70	160	Ω
							–40°C to +85°C			200	
							–55°C to +125°C			240	
					0	6	25°C		60	140	
							–40°C to +85°C			175	
							–55°C to +125°C			210	
					–4.5	4.5	25°C		40	120	
							–40°C to +85°C			150	
							–55°C to +125°C			180	
			V_{CC} to V_{EE}		0	4.5	25°C		90	180	
							–40°C to +85°C			225	
							–55°C to +125°C			270	
					0	6	25°C		80	160	
							–40°C to +85°C			200	
							–55°C to +125°C			240	
					–4.5	4.5	25°C		45	130	
							–40°C to +85°C			162	
							–55°C to +125°C			195	
Δr_{ON}	Maximum ON resistance between any two channels				0	4.5	25°C		10		Ω
					0	6	25°C		8.5		
					–4.5	4.5	25°C		5		

Electrical Characteristics: HC Devices (continued)

PARAMETERS			TEST CONDITIONS					MIN	TYP	MAX	UNIT
			V_{IS} (V)	V_I (V)	V_{EE} (V)	V_{CC} (V)	T_A				
I_{IZ}	Switch ON/OFF leakage current	1 and 2 channels	For switch OFF: When $V_{IS} = V_{CC}$, $V_{OS} = V_{EE}$; When $V_{IS} = V_{EE}$, $V_{OS} = V_{CC}$, For switch ON: All applicable combinations of V_{IS} and V_{OS} voltage levels	V_{IL} or V_{IH}	0	6	25°C			±0.1	µA
							–40°C to +85°C			±1	
							–55°C to +125°C			±1	
		4053			–5	5	25°C			±0.1	
							–40°C to +85°C			±1	
							–55°C to +125°C			±1	
		4 channels			0	6	25°C			±0.1	
							–40°C to +85°C			±1	
							–55°C to +125°C			±1	
		4052			–5	5	25°C			±0.2	
							–40°C to +85°C			±2	
							–55°C to +125°C			±2	
		8 channels			0	6	25°C			±0.2	
							–40°C to +85°C			±2	
							–55°C to +125°C			±2	
		4051			–5	5	25°C			±0.4	
							–40°C to +85°C			±4	
							–55°C to +125°C			±4	
I_{IL}	Control input leakage current			V_{CC} or GND	0	6	25°C			±0.1	µA
							–40°C to +85°C			±1	
							–55°C to +125°C			±1	
I_{CC}	Quiescent device current	$I_O = 0$	When $V_{IS} = V_{EE}$, $V_{OS} = V_{CC}$	V_{CC} or GND	0	6	25°C			8	µA
							–40°C to +85°C			80	
							–55°C to +125°C			160	
			When $V_{IS} = V_{CC}$, $V_{OS} = V_{EE}$		–5	5	25°C			16	
							–40°C to +85°C			160	
							–55°C to +125°C			320	

6.6 Electrical Characteristics: HCT Devices

PARAMETER			TEST CONDITIONS					MIN	TYP	MAX	UNIT
			V_{IS} (V)	V_I (V)	V_{EE} (V)	V_{CC} (V)	T_A				
V_{IH}	High-level input voltage					4.5 to 5.5	25°C	2			V
							–40°C to +85°C	2			
							–55°C to +125°C	2			
V_{IL}	Low-level input voltage					4.5 to 5.5	25°C			0.8	V
							–40°C to +85°C			0.8	
							–55°C to +125°C			0.8	
r_{ON}	ON resistance	I_O = 1 mA See Figure 6	V_{CC} or V_{EE}	V_{IL} or V_{IH}	0	4.5	25°C		70	160	Ω
							–40°C to +85°C			200	
							–55°C to +125°C			240	
					–4.5	4.5	25°C		40	120	
							–40°C to +85°C			150	
							–55°C to +125°C			180	
			V_{CC} to V_{EE}		0	4.5	25°C		90	180	
							–40°C to +85°C			225	
							–55°C to +125°C			270	
					–4.5	4.5	25°C		45	130	
							–40°C to +85°C			162	
							–55°C to +125°C			195	
Δr_{ON}	Maximum ON resistance between any two channels				0	4.5	25°C		10		Ω
					–4.5	4.5	25°C		5		

Electrical Characteristics: HCT Devices (continued)

PARAMETER			TEST CONDITIONS					MIN	TYP	MAX	UNIT
			V_{IS} (V)	V_I (V)	V_{EE} (V)	V_{CC} (V)	T_A				
I_{IZ}	Switch ON/OFF leakage current	1 and 2 channels	For switch OFF: When $V_{IS} = V_{CC}$, $V_{OS} = V_{EE}$; When $V_{IS} = V_{EE}$, $V_{OS} = V_{CC}$ For switch ON: All applicable combinations of V_{IS} and V_{OS} voltage levels	V_{IL} or V_{IH}	0	6	25°C			±0.1	µA
							–40°C to +85°C			±1	
							–55°C to +125°C			±1	
		4053			–5	5	25°C			±0.1	
							–40°C to +85°C			±1	
							–55°C to +125°C			±1	
		4 channels			0	6	25°C			±0.1	
							–40°C to +85°C			±1	
							–55°C to +125°C			±1	
		4052			–5	5	25°C			±0.2	
							–40°C to +85°C			±2	
							–55°C to +125°C			±2	
		8 channels			0	6	25°C			±0.2	
							–40°C to +85°C			±2	
							–55°C to +125°C			±2	
		4051			–5	5	25°C			±0.4	
							–40°C to +85°C			±4	
							–55°C to +125°C			±4	
I_{IL}	Control input leakage current			See (1)		5.5	25°C			±0.1	µA
							–40°C to +85°C			±1	
							–55°C to +125°C			±1	
I_{CC}	Quiescent device current	$I_O = 0$	When $V_{IS} = V_{EE}$, $V_{OS} = V_{CC}$	V_{CC} or GND	0	5.5	25°C			8	µA
							–40°C to +85°C			80	
							–55°C to +125°C			160	
			When $V_{IS} = V_{CC}$, $V_{OS} = V_{EE}$		–4.5	5.5	25°C			16	µA
							–40°C to +85°C			160	
							–55°C to +125°C			320	
ΔI_{CC}	Additional quiescent device current per input pin: 1 unit load (2)		ΔI_{CC} (2)	$V_{CC} - 2.1$		4.5 to 5.5	25°C		100	360	µA
							–40°C to +85°C			450	
							–55°C to +125°C			490	

(1) Any voltage between V_{CC} and GND.
(2) For dual-supply systems, theoretical worst-case (V_I = 2.4 V, V_{CC} = 5.5 V) specification is 1.8 mA.

6.7 Switching Characteristics, V_{CC} = 5 V

V_{CC} = 5 V, T_A = 25°C, input t_r, t_f = 6 ns

PARAMETER		TEST CONDITIONS		C_L (pF)	MIN	TYP	MAX	UNIT
t_{PHL}, t_{PLH}	Propagation delay	Switch IN to OUT	CDx4HC4051	15		4		ns
			CDx4HCT4051			4		
			CDx4HC4052			4		
			CDx4HCT4052			4		
			CDx4HC4053			4		
			CDx4HCT4053			4		
t_{PHZ}, t_{PLZ}		Switch turn-off (S or $\overline{E}$)	CDx4HC4051	15		19		ns
			CDx4HCT4051			19		
			CDx4HC4052			21		
			CDx4HCT4052			21		
			CDx4HC4053			18		
			CDx4HCT4053			18		
t_{PZH}, t_{PZL}		Switch turn-on (S or $\overline{E}$)	CDx4HC4051	15		19		ns
			CDx4HCT4051			23		
			CDx4HC4052			27		
			CDx4HCT4052			29		
			CDx4HC4053			18		
			CDx4HCT4053			20		
C_{PD}	Power dissipation capacitance(1)		CDx4HC4051			50		pF
			CDx4HCT4051			52		
			CDx4HC4052			74		
			CDx4HCT4052			76		
			CDx4HC4053			38		
			CDx4HCT4053			42		

(1) C_{PD} is used to determine the dynamic power consumption, per package. $P_D = C_{PD} V_{CC}^2 f_I + \sum (C_L + C_S) V_{CC}^2 f_O$, f_O = output frequency, f_I = input frequency, C_L = output load capacitance, C_S = switch capacitance, V_{CC} = supply voltage

6.8 Switching Characteristics, C_L = 50 pF

C_L = 50 pF, input t_r, t_f = 6 ns

PARAMETER			V_{EE} (V)	V_{CC} (V)	TEST CONDITIONS		MIN	MAX	UNIT
t_{PLH}, t_{PHL}	Propagation delay, switch in to out		0	2	T_A = 25°C	HC		60	ns
					T_A = –40°C to +85°C	HC		75	
					T_A = –55°C to +125°C	HC		90	
			0	4.5	T_A = 25°C	HC, HCT		12	
					T_A = –40°C to +85°C	HC, HCT		15	
					T_A = –55°C to +125°C	HC, HCT		18	
			0	6	T_A = 25°C	HC		10	
					T_A = –40°C to +85°C	HC		13	
					T_A = –55°C to +125°C	HC		15	
			–4.5	4.5	T_A = 25°C	HC, HCT		8	
					T_A = –40°C to +85°C	HC, HCT		10	
					T_A = –55°C to +125°C	HC, HCT		12	
t_{PHZ}, t_{PLZ}	Maximum switch turn OFF delay from S or $\overline{E}$ to switch output	4051	0	2	T_A = 25°C	HC		225	ns
					T_A = –40°C to +85°C	HC		280	
					T_A = –55°C to +125°C	HC		340	
			0	4.5	T_A = 25°C	HC, HCT		45	
					T_A = –40°C to +85°C	HC, HCT		56	
					T_A = –55°C to +125°C	HC, HCT		68	
			0	6	T_A = 25°C	HC		38	
					T_A = –40°C to +85°C	HC		48	
					T_A = –55°C to +125°C	HC		57	
			–4.5	4.5	T_A = 25°C	HC, HCT		32	
					T_A = –40°C to +85°C	HC, HCT		40	
					T_A = –55°C to +125°C	HC, HCT		48	
t_{PHZ}, t_{PLZ}	Maximum switch turn OFF delay from S or $\overline{E}$ to switch output	4052	0	2	T_A = 25°C	HC		250	ns
					T_A = –40°C to +85°C	HC		315	
					T_A = –55°C to +125°C	HC		375	
			0	4.5	T_A = 25°C	HC, HCT		50	
					T_A = –40°C to +85°C	HC, HCT		63	
					T_A = –55°C to +125°C	HC, HCT		75	
			0	6	T_A = 25°C	HC		43	
					T_A = –40°C to +85°C	HC		54	
					T_A = –55°C to +125°C	HC		65	
			–4.5	4.5	T_A = 25°C	HC		38	
						HCT		38	
					T_A = –40°C to +85°C	HC		48	
						HCT		48	
					T_A = –55°C to +125°C	HC		57	
						HCT		57	

Switching Characteristics, C_L = 50 pF (continued)

C_L = 50 pF, input t_r, t_f = 6 ns

PARAMETER			V_{EE} (V)	V_{CC} (V)	TEST CONDITIONS		MIN	MAX	UNIT
t_{PHZ}, t_{PLZ}	Maximum switch turn OFF delay from S or $\overline{E}$ to switch output	4053	0	2	T_A = 25°C	HC		210	ns
					T_A = –40°C to +85°C	HC		265	
					T_A = –55°C to +125°C	HC		315	
			0	4.5	T_A = 25°C	HC		42	
						HCT		44	
					T_A = –40°C to +85°C	HC		53	
						HCT		53	
					T_A = –55°C to +125°C	HC		63	
						HCT		66	
			0	6	T_A = 25°C	HC		36	
					T_A = –40°C to +85°C	HC		45	
					T_A = –55°C to +125°C	HC		54	
			–4.5	4.5	T_A = 25°C	HC		29	
						HCT		31	
					T_A = –40°C to +85°C	HC		36	
						HCT		39	
					T_A = –55°C to +125°C	HC		44	
						HCT		47	
t_{PZL}, t_{PZH}	Maximum switch turn ON delay from S or $\overline{E}$ to switch output	4051	0	2	T_A = 25°C	HC		225	ns
					T_A = –40°C to +85°C	HC		280	
					T_A = –55°C to +125°C	HC		340	
			0	4.5	T_A = 25°C	HC		45	
						HCT		55	
					T_A = –40°C to +85°C	HC		56	
						HCT		69	
					T_A = –55°C to +125°C	HC		68	
						HCT		83	
			0	6	T_A = 25°C	HC		38	
					T_A = –40°C to +85°C	HC		48	
					T_A = –55°C to +125°C	HC		57	
			–4.5	4.5	T_A = 25°C	HC		32	
						HCT		39	
					T_A = –40°C to +85°C	HC		40	
						HCT		49	
					T_A = –55°C to +125°C	HC		48	
						HCT		59	

Switching Characteristics, C_L = 50 pF (continued)

C_L = 50 pF, input t_r, t_f = 6 ns

PARAMETER			V_{EE} (V)	V_{CC} (V)	TEST CONDITIONS		MIN	MAX	UNIT
t_{PZL}, t_{PZH}	Maximum switch turn ON delay from S or $\overline{E}$ to switch output	4052	0	2	T_A = 25°C	HC		325	ns
					T_A = –40°C to +85°C	HC		405	
					T_A = –55°C to +125°C	HC		490	
			0	4.5	T_A = 25°C	HC		65	
						HCT		70	
					T_A = –40°C to +85°C	HC		81	
						HCT		68	
					T_A = –55°C to +125°C	HC		98	
						HCT		105	
			0	6	T_A = 25°C	HC		55	
					T_A = –40°C to +85°C	HC		69	
					T_A = –55°C to +125°C	HC		83	
			–4.5	4.5	T_A = 25°C	HC		46	
						HCT		48	
					T_A = –40°C to +85°C	HC		58	
						HCT		60	
					T_A = –55°C to +125°C	HC		69	
						HCT		72	
t_{PZL}, t_{PZH}	Maximum switch turn ON delay from S or $\overline{E}$ to switch output	4053	0	2	T_A = 25°C	HC		220	ns
					T_A = –40°C to +85°C	HC		275	
					T_A = –55°C to +125°C	HC		330	
			0	4.5	T_A = 25°C	HC		44	
						HCT		48	
					T_A = –40°C to +85°C	HC		55	
						HCT		60	
					T_A = –55°C to +125°C	HC		66	
						HCT		72	
			0	6	T_A = 25°C	HC		37	
					T_A = –40°C to +85°C	HC		47	
					T_A = –55°C to +125°C	HC		56	
			–4.5	4.5	T_A = 25°C	HC		31	
						HCT		34	
					T_A = –40°C to +85°C	HC		39	
						HCT		43	
					T_A = –55°C to +125°C	HC		47	
						HCT		51	
C_I	Input (control) capacitance				T_A = 25°C	HC, HCT		10	pF
					T_A = –40°C to +85°C	HC, HCT		10	
					T_A = –55°C to +125°C	HC, HCT		10	

6.9 Analog Channel Specifications

Typical values at T_A = 25°C

PARAMETER		TEST CONDITIONS	HC, HCT TYPES	V_{EE} (V)	V_{CC} (V)	TYP	UNIT
C_I	Switch input capacitance		All			5	pF
C_{COM}	Common output capacitance		4051			25	pF
			4052			12	
			4053			8	
f_{MAX}	Minimum switch frequency response at –3 dB (see Figure 3, Figure 5, and Figure 7)	See Figure 10 (1) (2)	4051	–2.25	2.25	145	MHz
			4052			165	
			4053			200	
			4051	–4.5	4.5	180	
			4052			185	
			4053			200	
	Sine-wave distortion	See Figure 12	All	–2.25%	2.25%	0.035%	
			All	–4.5%	4.5%	0.018%	
	Switch OFF signal feedthrough (see Figure 4, Figure 6, and Figure 8)	See Figure 14 (2) (3)	4051	–2.25	2.25	–73	dB
			4052			–65	
			4053			–64	
			4051	–4.5	4.5	–75	
			4052			–67	
			4053			–66	

(1) Adjust input voltage to obtain 0 dBm at V_{OS} for f_{IN} = 1 MHz.
(2) V_{IS} is centered at (V_{CC} – V_{EE}) / 2.
(3) Adjust input for 0 dBm.

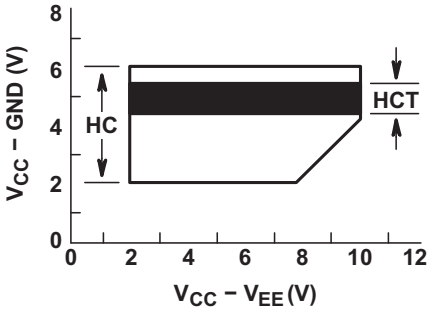


Figure 1. Recommended Operating Area as a Function of (V_{CC} – V_{EE})

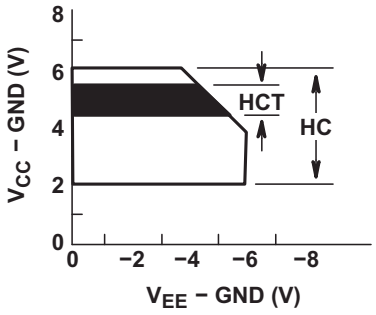


Figure 2. Recommended Operating Area as a Function of (V_{EE} – GND)

6.10 Typical Characteristics

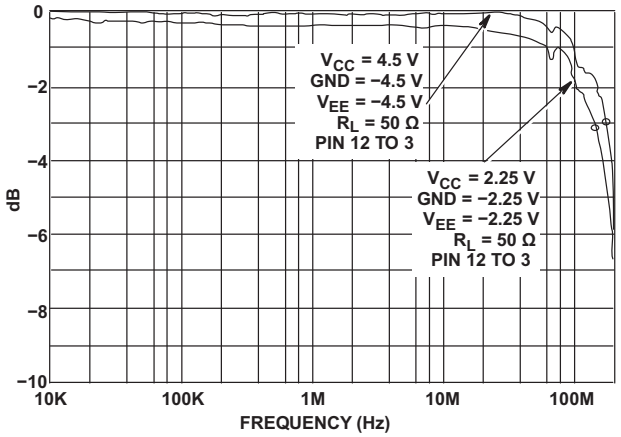


Figure 3. Channel ON Bandwidth (HC and HCT4051)

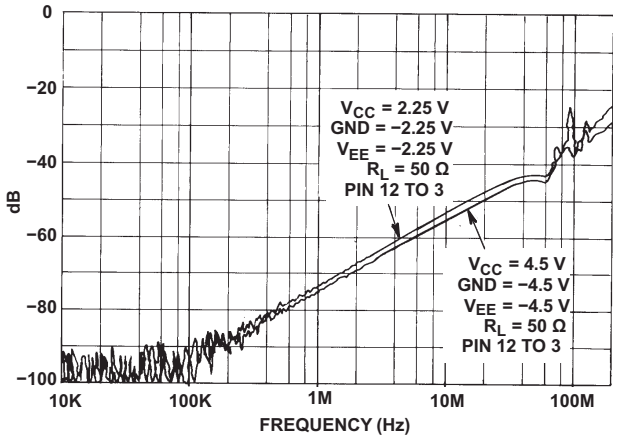


Figure 4. Channel OFF Feedthrough (HC and HCT4051)

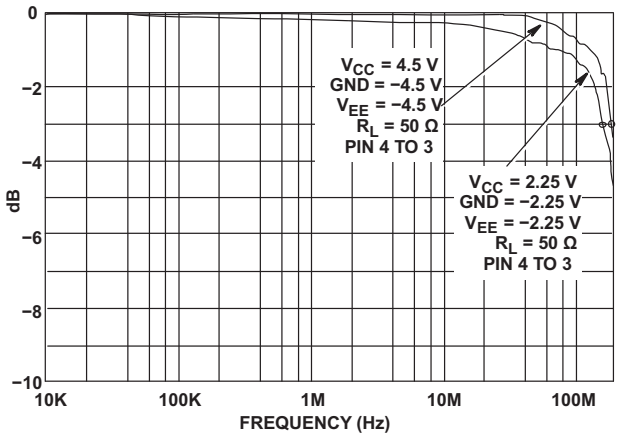


Figure 5. Channel ON Bandwidth (HC and HCT4052)

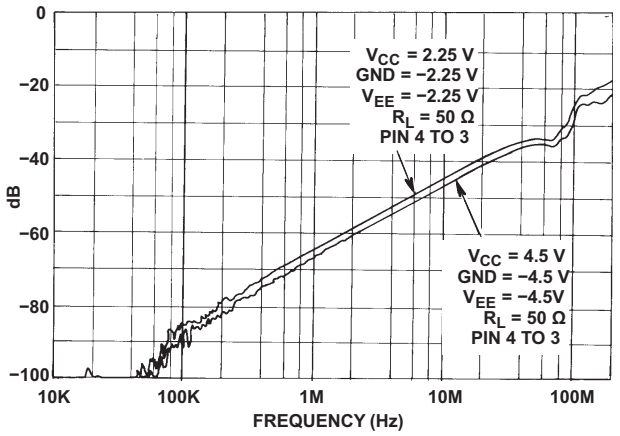


Figure 6. Channel OFF Feedthrough (HC and HCT4052)

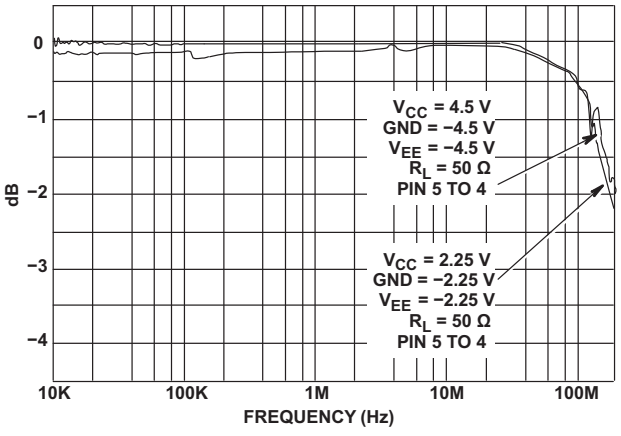


Figure 7. Channel ON Bandwidth (HC and HCT4053)

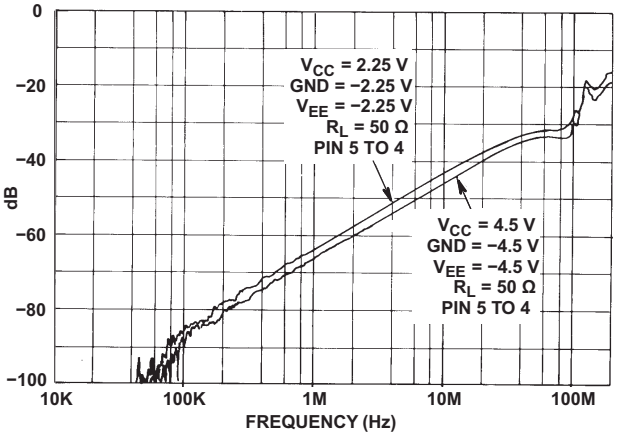
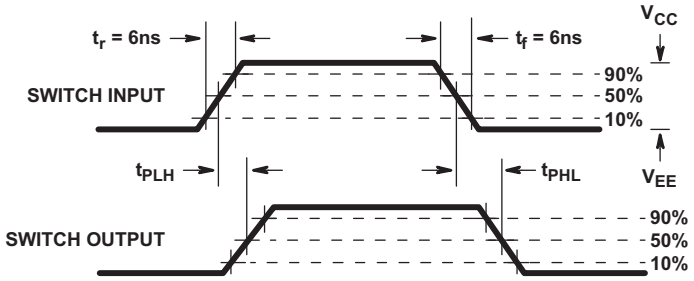
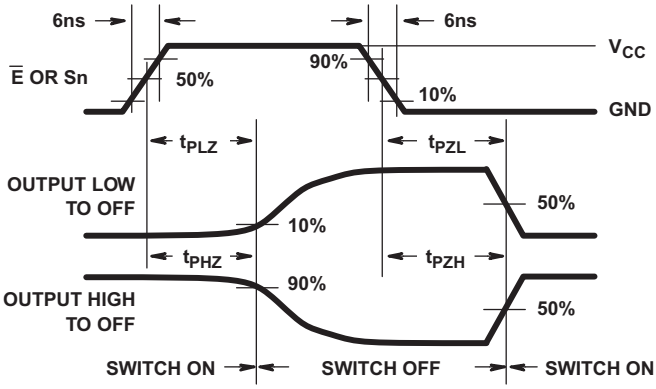


Figure 8. Channel OFF Feedthrough (HC and HCT4053)

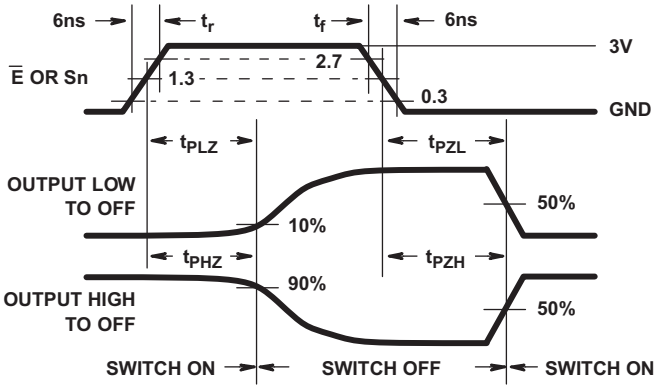
7 Parameter Measurement Information



(FIGURE A)



(FIGURE B) HC TYPES



(FIGURE C) HCT TYPES

Figure 9. Switch Propagation Delay, Turn-On, Turn-Off Times

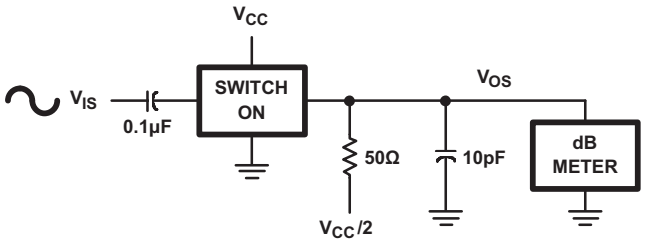


Figure 10. Frequency Response Test Circuit

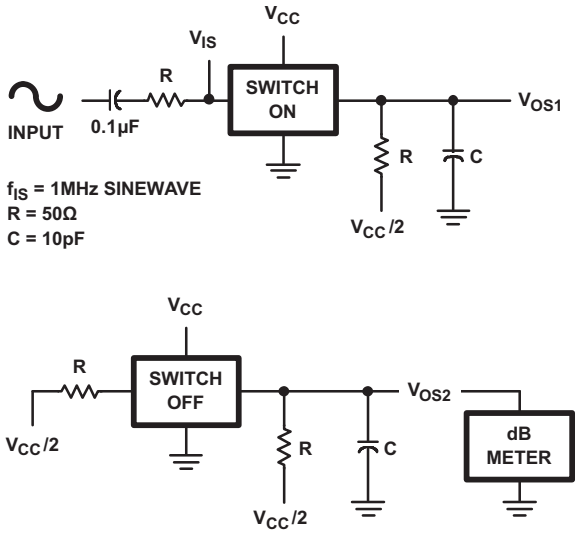


Figure 11. Crosstalk Between Two Switches Test Circuit

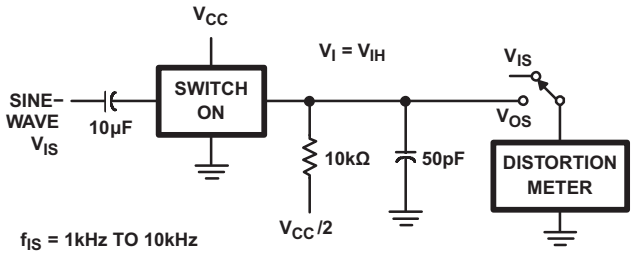


Figure 12. ¼Sine-Wave Distortion Test Circuit

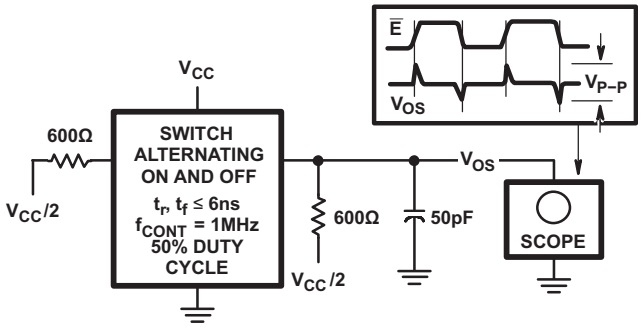


Figure 13. Control to Switch Feedthrough Noise Test Circuit

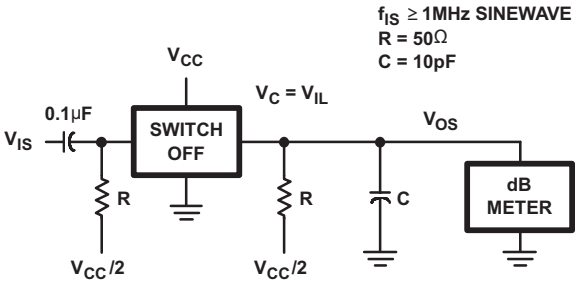


Figure 14. Switch OFF Signal Feedthrough

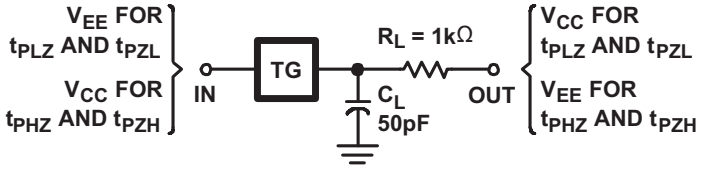


Figure 15. Switch ON/OFF Propagation Delay Test Circuit

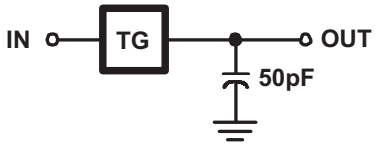


Figure 16. Switch In to Switch Out Propagation Delay Test Circuit

8 Detailed Description

8.1 Overview

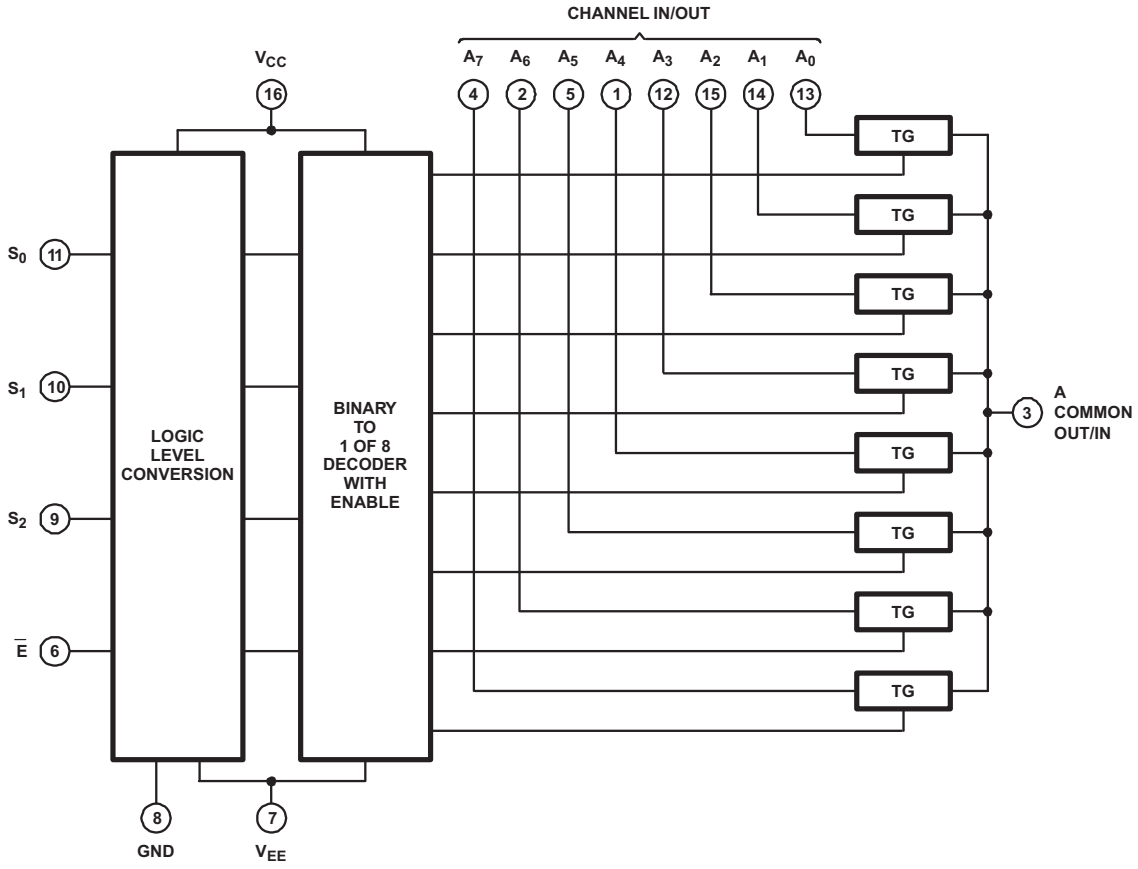
The CDx4HCx4051 devices are a single 8-channel multiplexer having three binary control inputs, S_0, S_1, and S_2 and an $\overline{\text{ENABLE}}$ input. The three binary signals select 1 of 8 channels to be turned on, and connect one of the 8 inputs to the output.

The CDx4HCx4052 devices are a differential 4-channel multiplexer having two binary control inputs, S_0 and S_1, and an $\overline{\text{ENABLE}}$ input. The two binary input signals select 1 of 4 pairs of channels to be turned on and connect the analog inputs to the outputs.

The CDx4HCx4053 devices are a triple 2-channel multiplexer having three separate digital control inputs, S_0, S_1, and S_2 and an $\overline{\text{ENABLE}}$ input. Each control input selects one of a pair of channels that are connected in a single-pole, double-throw configuration.

When these devices are used as demultiplexers, the CHANNEL IN/OUT terminals are the outputs and the COMMON OUT/IN terminals are the inputs.

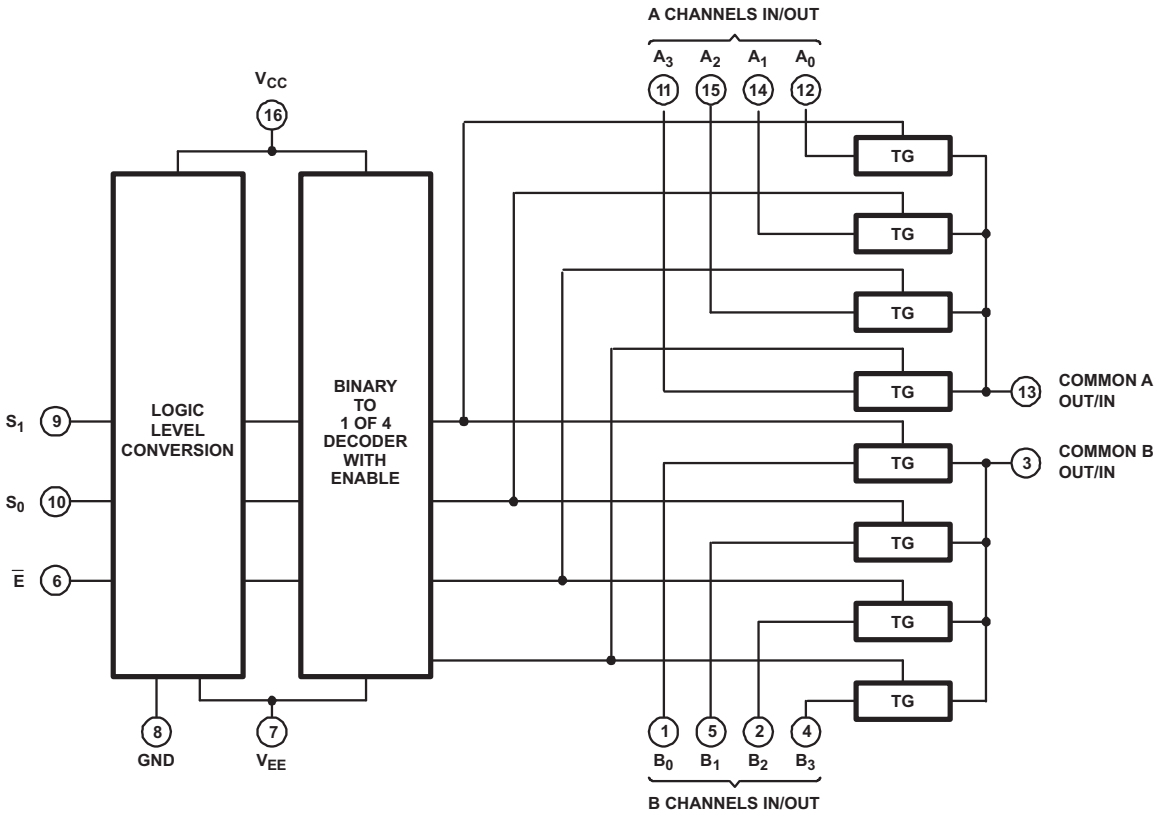
8.2 Functional Block Diagrams



All inputs are protected by standard CMOS protection network.

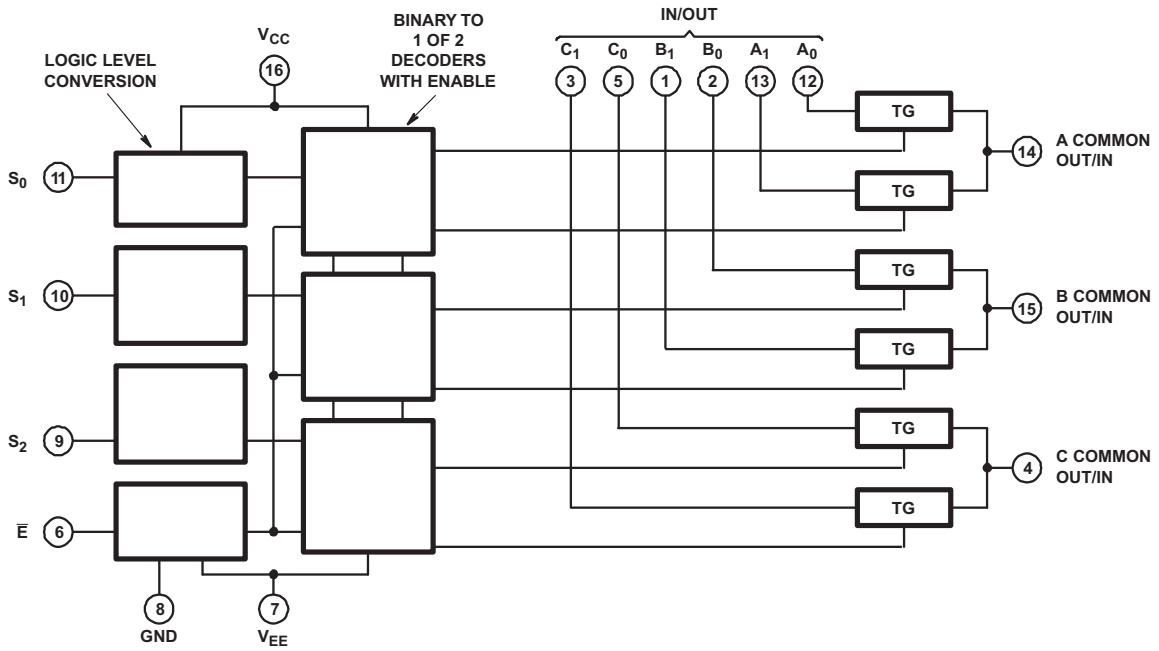
Figure 17. CDx4HCx4051 Functional Block Diagram

Functional Block Diagrams (continued)



All inputs are protected by standard CMOS protection network.

Figure 18. CDx4HCx4052 Functional Block Diagram



All inputs are protected by standard CMOS protection network.

Figure 19. CDx4HCx4053 Functional Block Diagram

8.3 Feature Description

The CDx4HCx405x line of multiplexers and demultiplexers can accept a wide range of analog signal levels from –5 to +5 V. They have low ON resistance, typically 70-Ω for $V_{CC} – V_{EE}$ = 4.5 V and 40-Ω for $V_C – V_{EE}$ = 4.5 V, which allows for very little signal loss through the switch.

Binary address decoding on chip makes channel selection easy. When channels are changed, a break-before-make system eliminates channel overlap.

8.4 Device Functional Modes

Table 1. CD54HC4051, CD74HC4051, CD54HCT4051, CD74HCT4051 Function Table(1)

INPUT STATES				ON CHANNEL
ENABLE	S_2	S_1	S_0	
L	L	L	L	A0
L	L	L	H	A1
L	L	H	L	A2
L	L	H	H	A3
L	H	L	L	A4
L	H	L	H	A5
L	H	H	L	A6
L	H	H	H	A7
H	X	X	X	None

(1) X = Don't care

Table 2. CD54HC4052, CD74HC4052, CD54HCT4052, CD74HCT4052 Function Table(1)

INPUT STATES			ON CHANNELS
ENABLE	S_1	S_0	
L	L	L	A0, B0
L	L	H	A1, B1
L	H	L	A2, B2
L	H	H	A3, B3
H	X	X	None

(1) X = Don't care

Table 3. CD54HC4053, CD74HC4053, CD54HCT4053, CD74HCT4053 Function Table(1)

INPUT STATES				ON CHANNELS
ENABLE	S_2	S_1	S_0	
L	L	L	L	C0, B0, A0
L	L	L	H	C0, B0, A1
L	L	H	L	C0, B1, A0
L	L	H	H	C0, B1, A1
L	H	L	L	C1, B0, A0
L	H	L	H	C1, B0, A1
L	H	H	L	C1, B1, A0
L	H	H	H	C1, B1, A1
H	X	X	X	None

(1) X = Don't care

9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The CDx4HCx405x line of multiplexers and demultiplexers can be used for a wide variety of applications.

9.2 Typical Application

One application of the CD74HC4051 device is used in conjunction with a microcontroller to poll a keypad. Figure 20 shows the basic schematic for such a polling system. The microcontroller uses the channel-select pins to cycle through the different channels while reading the input to see if a user is pressing any of the keys. This is a very robust setup that allows for simultaneous key presses with very little power consumption. It also uses very few pins on the microcontroller. The down side of polling is that the microcontroller must frequently scan the keys for a press.

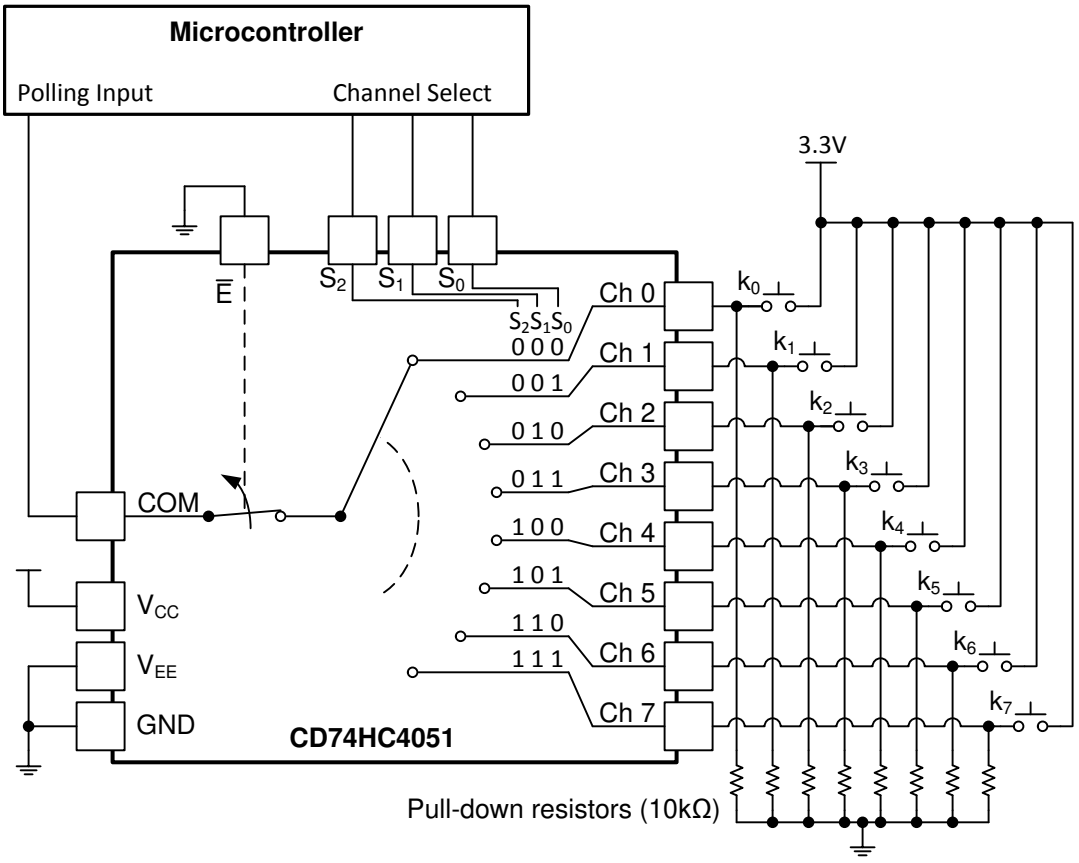


Figure 20. CD74HC4051 Being Used to Help Read Button Presses on a Keypad

9.2.1 Design Requirements

These devices use CMOS technology and have balanced output drive. Take care to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads, so routing and load conditions must be considered to prevent ringing.

Typical Application (continued)

See Table 4 for the input loading details.

Table 4. HCT Input Loading Table

TYPE	INPUT	UNIT LOADS(1)
4051, 4053	All	0.5
4052	All	0.4

(1) Unit load is ΔI_{CC} limit specified in *Specifications*, for example, 360-mA MAX at 25°C.

9.2.2 Detailed Design Procedure

1. Recommended input conditions:
   - For switch time specifications, see propagation delay times in *Electrical Characteristics: HC Devices*.
   - Inputs must not be pushed more than 0.5 V above V_{DD} or below V_{EE}.
   - For input voltage level specifications for control inputs, see V_{IH} and V_{IL} in *Electrical Characteristics: HC Devices*.
2. Recommended output conditions:
   - Outputs must not be pulled above V_{DD} or below V_{EE}.
3. Input and output current consideration:
   - The CDx4HCx405x series of parts do not have internal current-drive circuitry, and thus cannot sink or source current. Any current will be passed through the device.

9.2.3 Application Curve

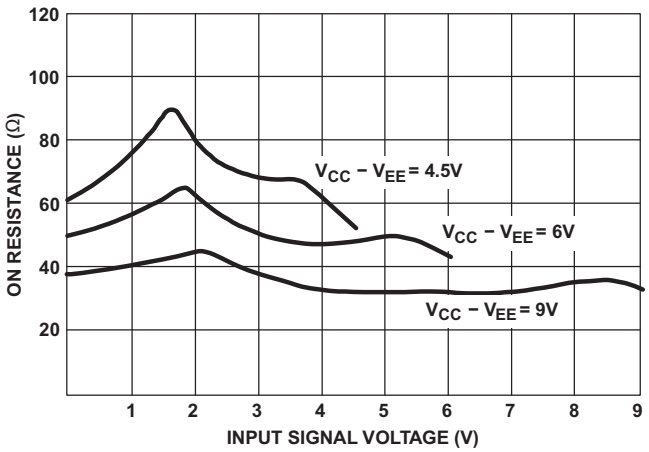


Figure 21. Typical ON Resistance vs Input Signal Voltage

10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Electrical Characteristics: HC Devices*.

Each V_{CC} terminal must have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a 0.1-µF bypass capacitor is recommended. If there are multiple pins labeled V_{CC}, then a 0.01-µF or 0.022-µF capacitor is recommended for each V_{CC} because the V_{CC} pins will be tied together internally. For devices with dual-supply pins operating at different voltages, for example V_{CC} and V_{DD}, a 0.1-µF bypass capacitor is recommended for each supply pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. A 0.1-µF and a 1-µF capacitor are commonly used in parallel. For best results, the bypass capacitor or capacitors must be installed as close as possible to the power terminal.

11 Layout

11.1 Layout Guidelines

Reflections and matching are closely related to loop antenna theory, but different enough to warrant their own discussion. When a PCB trace turns a corner at a 90° angle, a reflection can occur. This is primarily due to the change in width of the trace. At the apex of the turn, the trace width is increased to 1.414 times its width. This change in width upsets the transmission line characteristics, especially the distributed capacitance and self-inductance of the trace, thus resulting in the reflection. Not all PCB traces can be straight, so they will have to turn corners. Figure 22 shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.

11.2 Layout Example

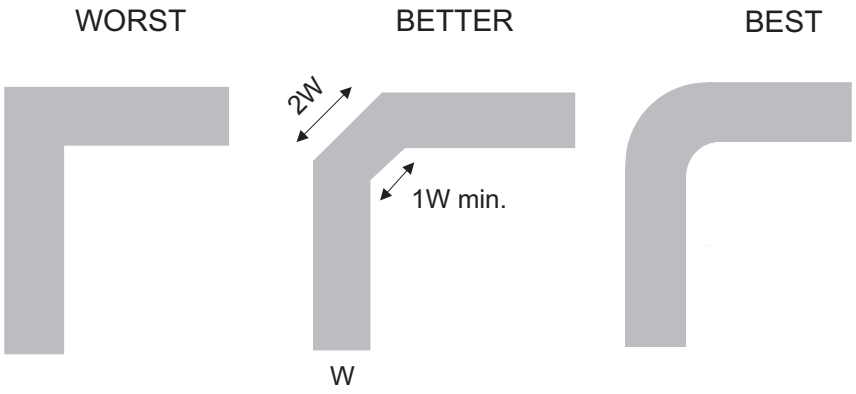


Figure 22. Trace Example

12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation see the following:

Implications of Slow or Floating CMOS Inputs, SCBA004

12.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 5. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
CD54HC4051	Click here	Click here	Click here	Click here	Click here
CD74HC4051	Click here	Click here	Click here	Click here	Click here
CD54HCT4051	Click here	Click here	Click here	Click here	Click here
CD74HCT4051	Click here	Click here	Click here	Click here	Click here
CD54HC4052	Click here	Click here	Click here	Click here	Click here
CD74HC4052	Click here	Click here	Click here	Click here	Click here
CD54HCT4052	Click here	Click here	Click here	Click here	Click here
CD74HCT4052	Click here	Click here	Click here	Click here	Click here
CD54HC4053	Click here	Click here	Click here	Click here	Click here
CD74HC4053	Click here	Click here	Click here	Click here	Click here
CD54HCT4053	Click here	Click here	Click here	Click here	Click here
CD74HCT4053	Click here	Click here	Click here	Click here	Click here

12.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.4 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community ***TI's Engineer-to-Engineer (E2E) Community.*** Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support ***TI's Design Support*** Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.5 Trademarks

E2E is a trademark of Texas Instruments.
All other trademarks are the property of their respective owners.

12.6 Electrostatic Discharge Caution

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.7 Glossary

SLYZ022 — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
5962-8775401EA	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-8775401EA CD54HC4053F3A	Samples
5962-8855601EA	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-8855601EA CD54HC4052F3A	Samples
5962-9065401MEA	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9065401ME A CD54HCT4051F3A	Samples
CD54HC4051F	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54HC4051F	Samples
CD54HC4051F3A	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54HC4051F3A	Samples
CD54HC4052F	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54HC4052F	Samples
CD54HC4052F3A	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-8855601EA CD54HC4052F3A	Samples
CD54HC4053F	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54HC4053F	Samples
CD54HC4053F3A	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-8775401EA CD54HC4053F3A	Samples
CD54HCT4051F3A	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9065401ME A CD54HCT4051F3A	Samples
CD74HC4051E	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC4051E	Samples
CD74HC4051EE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC4051E	Samples
CD74HC4051M	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4051M	Samples
CD74HC4051M96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU | CU SN	Level-1-260C-UNLIM	-55 to 125	HC4051M	Samples
CD74HC4051M96E4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4051M	Samples
CD74HC4051M96G3	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-55 to 125	HC4051M	Samples
CD74HC4051M96G4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4051M	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CD74HC4051ME4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4051M	Samples
CD74HC4051MG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4051M	Samples
CD74HC4051MT	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4051M	Samples
CD74HC4051NSR	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4051M	Samples
CD74HC4051NSRE4	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4051M	Samples
CD74HC4051PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU | CU SN	Level-1-260C-UNLIM	-55 to 125	HJ4051	Samples
CD74HC4051PWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4051	Samples
CD74HC4051PWT	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4051	Samples
CD74HC4051PWTG4	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4051	Samples
CD74HC4052E	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC4052E	Samples
CD74HC4052EE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC4052E	Samples
CD74HC4052M	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4052M	Samples
CD74HC4052M96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU | CU SN	Level-1-260C-UNLIM	-55 to 125	HC4052M	Samples
CD74HC4052M96E4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4052M	Samples
CD74HC4052M96G4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4052M	Samples
CD74HC4052ME4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4052M	Samples
CD74HC4052MG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4052M	Samples
CD74HC4052MT	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4052M	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CD74HC4052MTG4	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4052M	Samples
CD74HC4052NSR	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4052M	Samples
CD74HC4052NSRG4	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4052M	Samples
CD74HC4052PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4052	Samples
CD74HC4052PWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4052	Samples
CD74HC4052PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU | CU SN	Level-1-260C-UNLIM	-55 to 125	HJ4052	Samples
CD74HC4052PWRE4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4052	Samples
CD74HC4052PWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4052	Samples
CD74HC4052PWT	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4052	Samples
CD74HC4053E	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC4053E	Samples
CD74HC4053EE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC4053E	Samples
CD74HC4053M	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4053M	Samples
CD74HC4053M96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU | CU SN	Level-1-260C-UNLIM	-55 to 125	HC4053M	Samples
CD74HC4053M96E4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4053M	Samples
CD74HC4053M96G3	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-55 to 125	HC4053M	Samples
CD74HC4053M96G4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4053M	Samples
CD74HC4053ME4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4053M	Samples
CD74HC4053MG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4053M	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CD74HC4053MT	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4053M	Samples
CD74HC4053NSR	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4053M	Samples
CD74HC4053PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4053	Samples
CD74HC4053PWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4053	Samples
CD74HC4053PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU | CU SN	Level-1-260C-UNLIM	-55 to 125	HJ4053	Samples
CD74HC4053PWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4053	Samples
CD74HC4053PWT	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HJ4053	Samples
CD74HCT4051E	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT4051E	Samples
CD74HCT4051M	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4051M	Samples
CD74HCT4051M96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4051M	Samples
CD74HCT4051M96E4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4051M	Samples
CD74HCT4051M96G4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4051M	Samples
CD74HCT4051ME4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4051M	Samples
CD74HCT4051MG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4051M	Samples
CD74HCT4051MT	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4051M	Samples
CD74HCT4051MTG4	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4051M	Samples
CD74HCT4052E	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT4052E	Samples
CD74HCT4052EE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT4052E	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CD74HCT4052M	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4052M	Samples
CD74HCT4052M96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4052M	Samples
CD74HCT4052M96G4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4052M	Samples
CD74HCT4052ME4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4052M	Samples
CD74HCT4052MG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4052M	Samples
CD74HCT4052MT	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4052M	Samples
CD74HCT4053E	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT4053E	Samples
CD74HCT4053EE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT4053E	Samples
CD74HCT4053M	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4053M	Samples
CD74HCT4053M96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4053M	Samples
CD74HCT4053M96E4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4053M	Samples
CD74HCT4053M96G4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4053M	Samples
CD74HCT4053ME4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4053M	Samples
CD74HCT4053MG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4053M	Samples
CD74HCT4053MT	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT4053M	Samples
CD74HCT4053PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU | CU SN	Level-1-260C-UNLIM	-55 to 125	HK4053	Samples
CD74HCT4053PWRE4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HK4053	Samples
CD74HCT4053PWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HK4053	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
CD74HCT4053PWT	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HK4053	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

OTHER QUALIFIED VERSIONS OF CD54HC4051, CD54HC4052, CD54HC4053, CD54HCT4051, CD74HC4051, CD74HC4052, CD74HC4053, CD74HCT4051 :

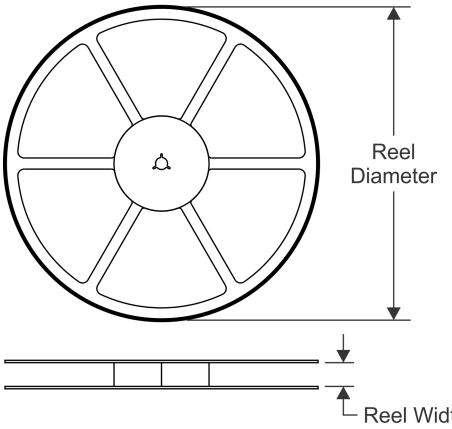
- Catalog: CD74HC4051, CD74HC4052, CD74HC4053, CD74HCT4051
- Automotive: CD74HC4051-Q1, CD74HCT4051-Q1, CD74HC4051-Q1, CD74HCT4051-Q1
- Enhanced Product: CD74HC4051-EP, CD74HC4051-EP
- Military: CD54HC4051, CD54HC4052, CD54HC4053, CD54HCT4051

NOTE: Qualified Version Definitions:

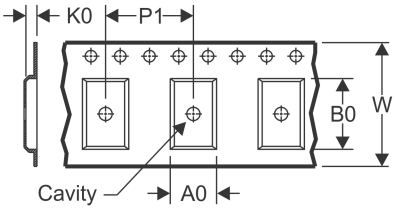
- Catalog - TI's standard catalog product
- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product - Supports Defense, Aerospace and Medical Applications
- Military - QML certified for Military and Defense Applications

TAPE AND REEL INFORMATION

REEL DIMENSIONS

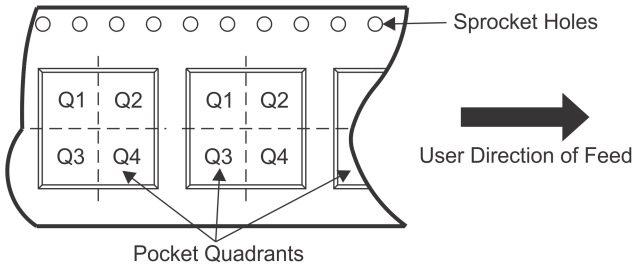


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

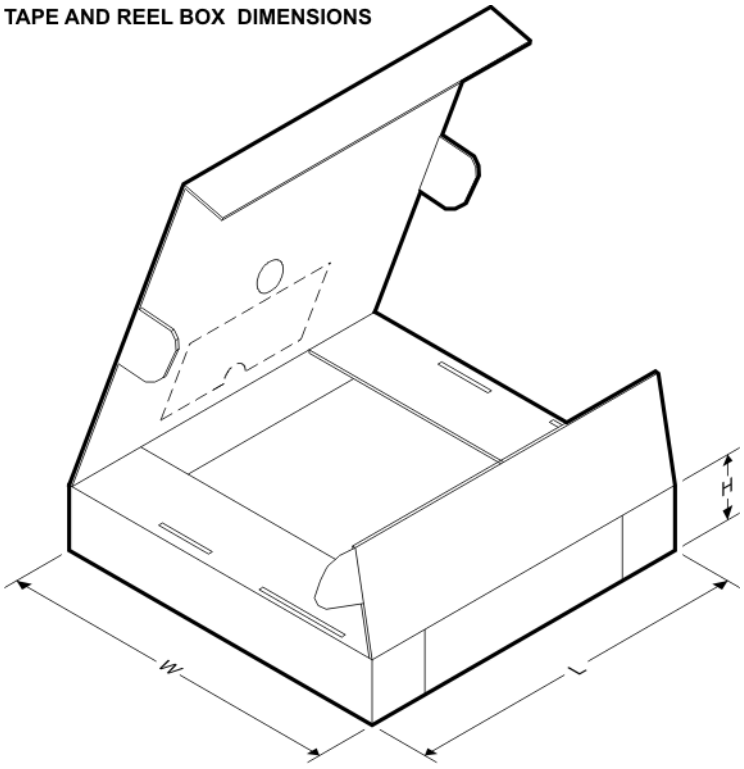


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HC4051M96	SOIC	D	16	2500	330.0	16.8	6.5	10.3	2.1	8.0	16.0	Q1
CD74HC4051M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74HC4051M96G3	SOIC	D	16	2500	330.0	16.8	6.5	10.3	2.1	8.0	16.0	Q1
CD74HC4051M96G4	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74HC4051PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC4051PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC4051PWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC4051PWT	TSSOP	PW	16	250	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC4052M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74HC4052M96	SOIC	D	16	2500	330.0	16.8	6.5	10.3	2.1	8.0	16.0	Q1
CD74HC4052M96G4	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74HC4052NSR	SO	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD74HC4052PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC4052PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC4052PWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC4052PWT	TSSOP	PW	16	250	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC4053M96	SOIC	D	16	2500	330.0	16.8	6.5	10.3	2.1	8.0	16.0	Q1
CD74HC4053M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HC4053M96G3	SOIC	D	16	2500	330.0	16.8	6.5	10.3	2.1	8.0	16.0	Q1
CD74HC4053M96G4	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74HC4053PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC4053PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC4053PWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HC4053PWT	TSSOP	PW	16	250	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HCT4051M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74HCT4052M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74HCT4053M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74HCT4053PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HCT4053PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HCT4053PWRG4	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
CD74HCT4053PWT	TSSOP	PW	16	250	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS

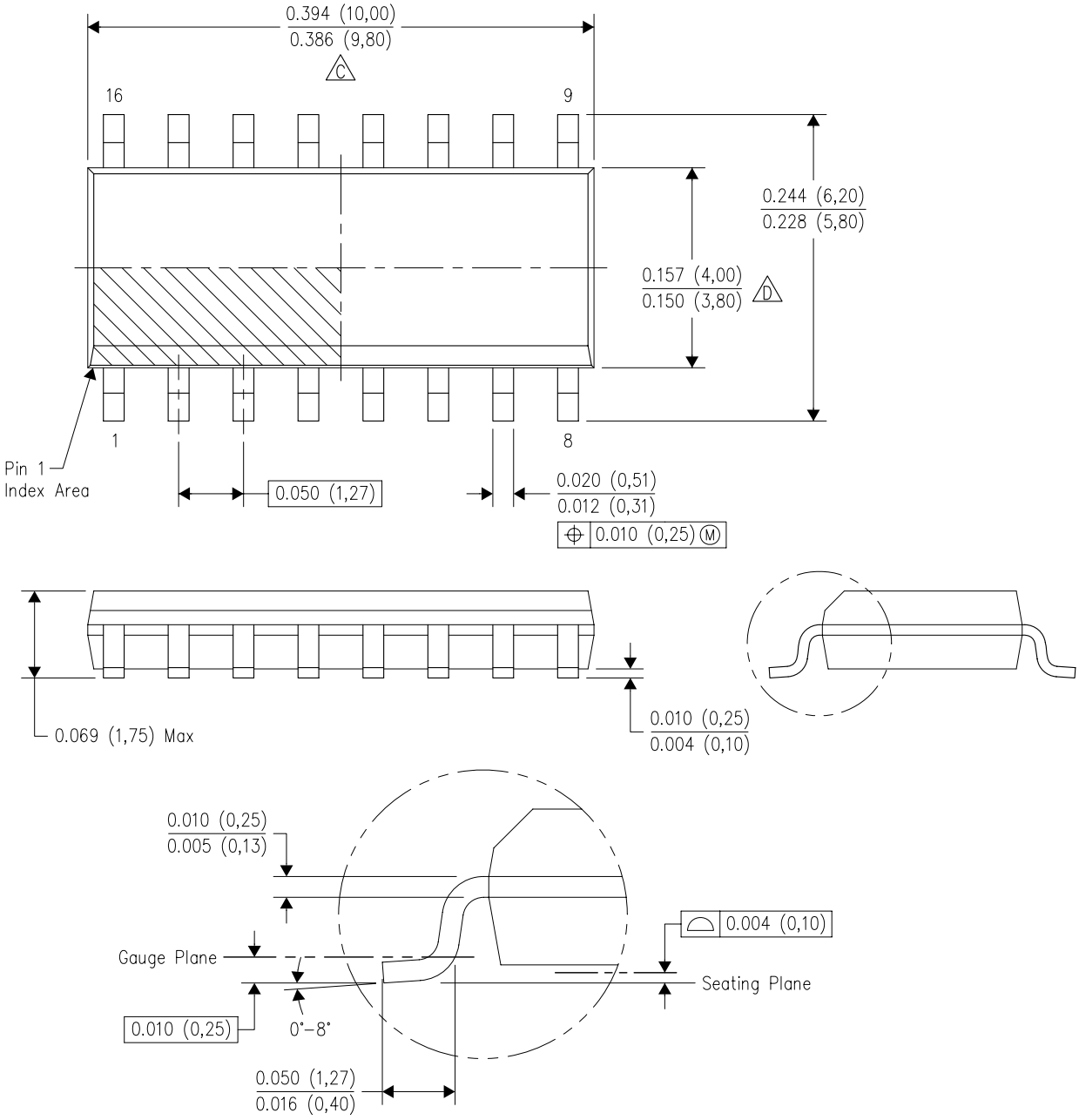


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HC4051M96	SOIC	D	16	2500	364.0	364.0	27.0
CD74HC4051M96	SOIC	D	16	2500	333.2	345.9	28.6
CD74HC4051M96G3	SOIC	D	16	2500	364.0	364.0	27.0
CD74HC4051M96G4	SOIC	D	16	2500	333.2	345.9	28.6

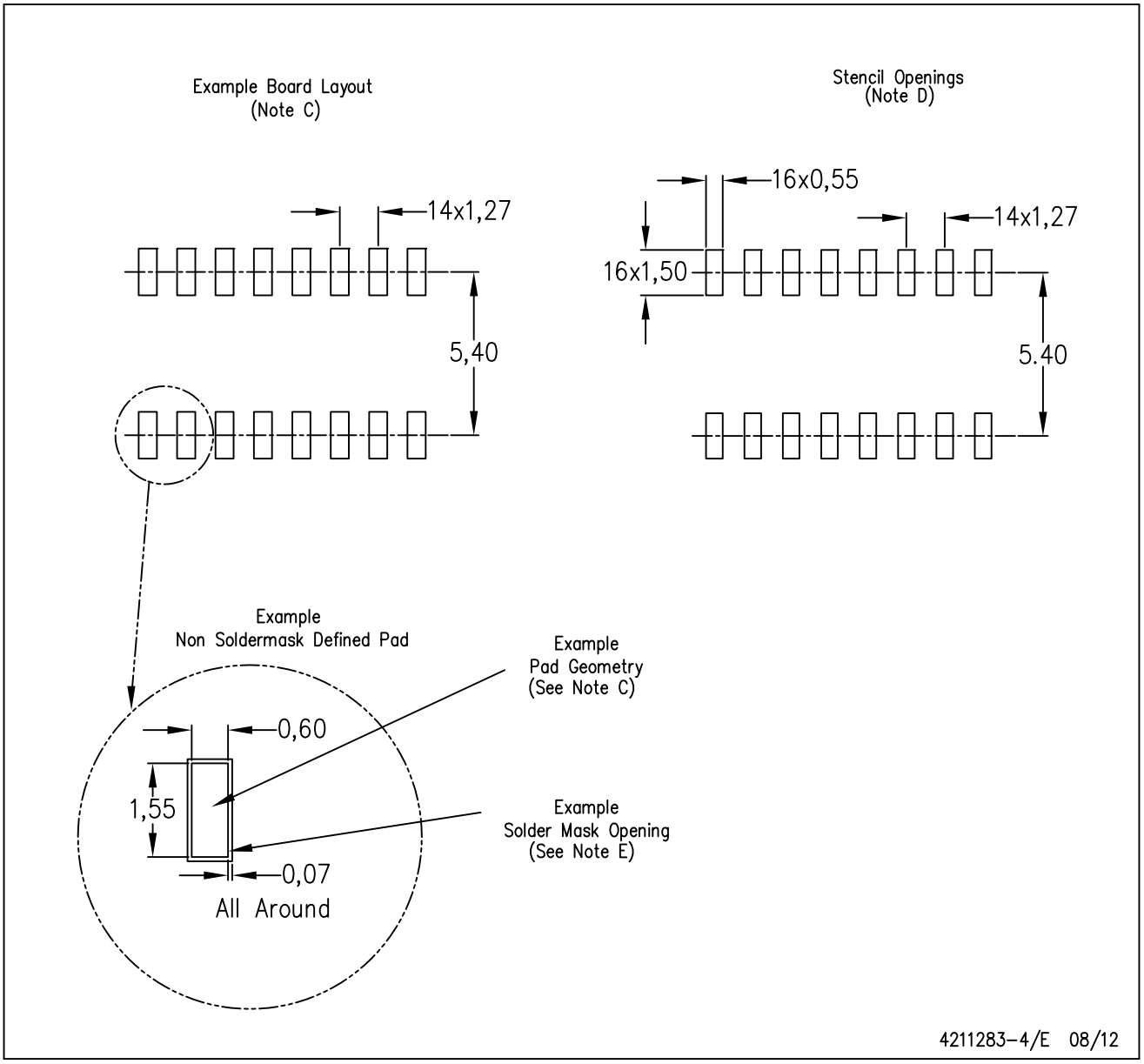
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HC4051PWR	TSSOP	PW	16	2000	367.0	367.0	35.0
CD74HC4051PWR	TSSOP	PW	16	2000	364.0	364.0	27.0
CD74HC4051PWRG4	TSSOP	PW	16	2000	367.0	367.0	35.0
CD74HC4051PWT	TSSOP	PW	16	250	367.0	367.0	35.0
CD74HC4052M96	SOIC	D	16	2500	333.2	345.9	28.6
CD74HC4052M96	SOIC	D	16	2500	364.0	364.0	27.0
CD74HC4052M96G4	SOIC	D	16	2500	333.2	345.9	28.6
CD74HC4052NSR	SO	NS	16	2000	367.0	367.0	38.0
CD74HC4052PWR	TSSOP	PW	16	2000	364.0	364.0	27.0
CD74HC4052PWR	TSSOP	PW	16	2000	367.0	367.0	35.0
CD74HC4052PWRG4	TSSOP	PW	16	2000	367.0	367.0	35.0
CD74HC4052PWT	TSSOP	PW	16	250	367.0	367.0	35.0
CD74HC4053M96	SOIC	D	16	2500	364.0	364.0	27.0
CD74HC4053M96	SOIC	D	16	2500	333.2	345.9	28.6
CD74HC4053M96G3	SOIC	D	16	2500	364.0	364.0	27.0
CD74HC4053M96G4	SOIC	D	16	2500	333.2	345.9	28.6
CD74HC4053PWR	TSSOP	PW	16	2000	367.0	367.0	35.0
CD74HC4053PWR	TSSOP	PW	16	2000	364.0	364.0	27.0
CD74HC4053PWRG4	TSSOP	PW	16	2000	367.0	367.0	35.0
CD74HC4053PWT	TSSOP	PW	16	250	367.0	367.0	35.0
CD74HCT4051M96	SOIC	D	16	2500	333.2	345.9	28.6
CD74HCT4052M96	SOIC	D	16	2500	333.2	345.9	28.6
CD74HCT4053M96	SOIC	D	16	2500	333.2	345.9	28.6
CD74HCT4053PWR	TSSOP	PW	16	2000	364.0	364.0	27.0
CD74HCT4053PWR	TSSOP	PW	16	2000	367.0	367.0	35.0
CD74HCT4053PWRG4	TSSOP	PW	16	2000	367.0	367.0	35.0
CD74HCT4053PWT	TSSOP	PW	16	250	367.0	367.0	35.0

D (R–PDSO–G16) PLASTIC SMALL OUTLINE



NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
D. Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
E. Reference JEDEC MS–012 variation AC.

D (R–PDSO–G16) PLASTIC SMALL OUTLINE

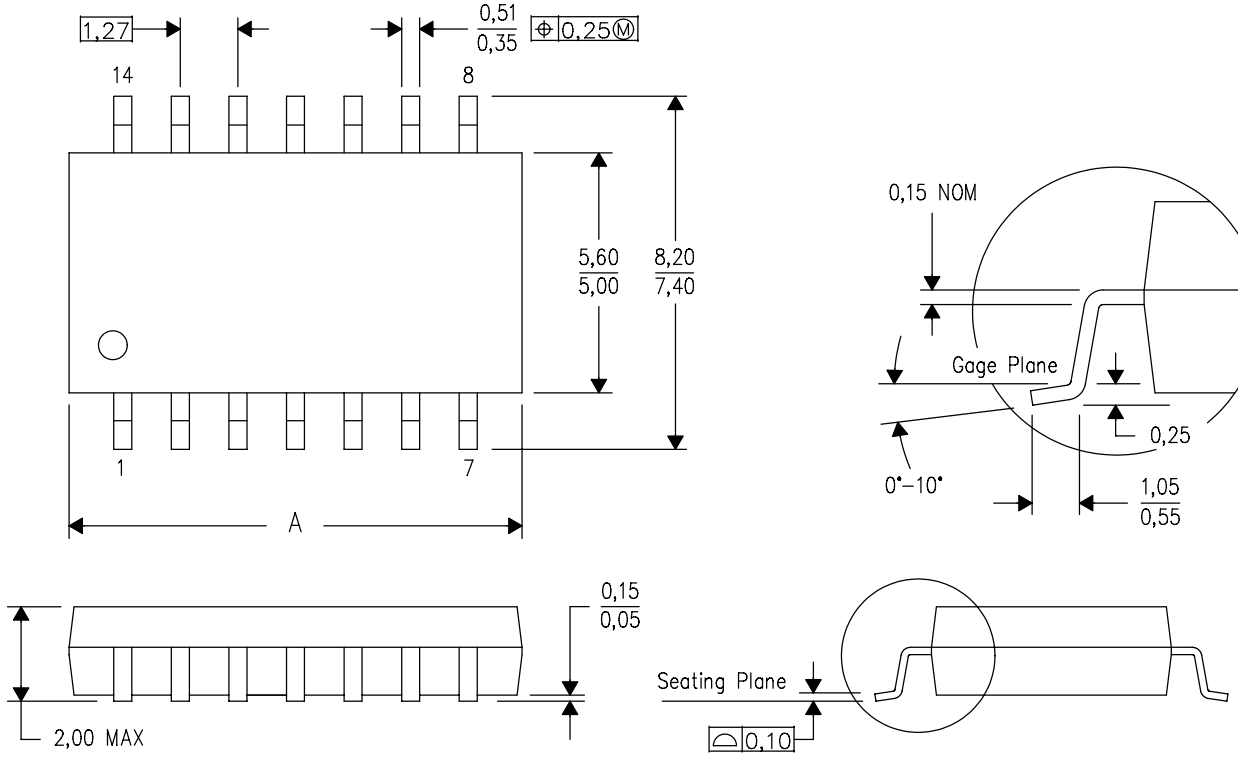


NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Publication IPC–7351 is recommended for alternate designs.
D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC–7525 for other stencil recommendations.
E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

MECHANICAL DATA

NS (R-PDSO-G)** **PLASTIC SMALL-OUTLINE PACKAGE**

14-PINS SHOWN



DIM \ PINS **	14	16	20	24
A MAX	10,50	10,50	12,90	15,30
A MIN	9,90	9,90	12,30	14,70

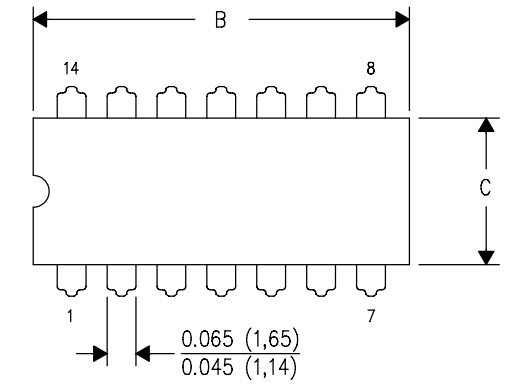
4040062/C 03/03

NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.

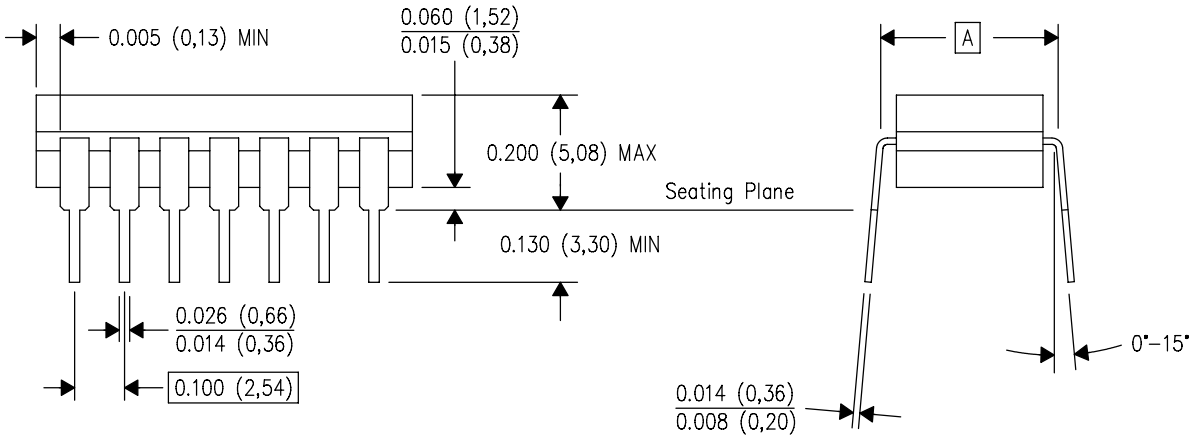
J (R–GDIP–T**)

14 LEADS SHOWN

CERAMIC DUAL IN–LINE PACKAGE



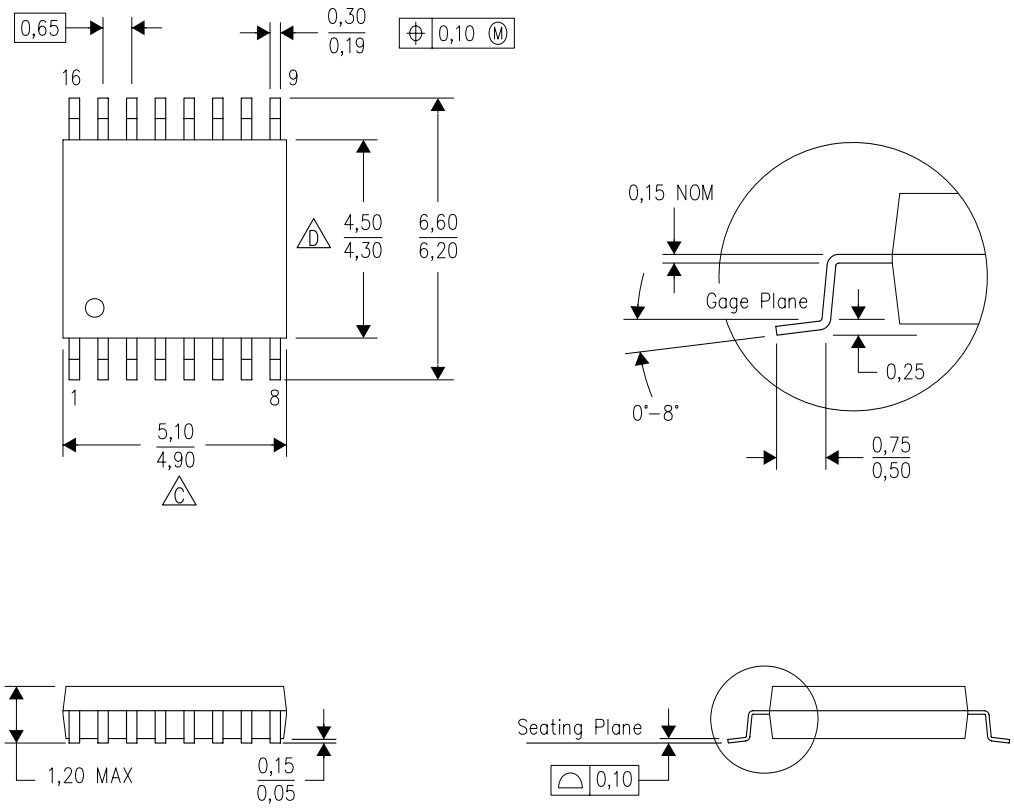
DIM \ PINS **	14	16	18	20
A	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC
B MAX	0.785 (19,94)	.840 (21,34)	0.960 (24,38)	1.060 (26,92)
B MIN	—	—	—	—
C MAX	0.300 (7,62)	0.300 (7,62)	0.310 (7,87)	0.300 (7,62)
C MIN	0.245 (6,22)	0.245 (6,22)	0.220 (5,59)	0.245 (6,22)



4040083/F 03/03

NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package is hermetically sealed with a ceramic lid using glass frit.
D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
E. Falls within MIL STD 1835 GDIP1–T14, GDIP1–T16, GDIP1–T18 and GDIP1–T20.

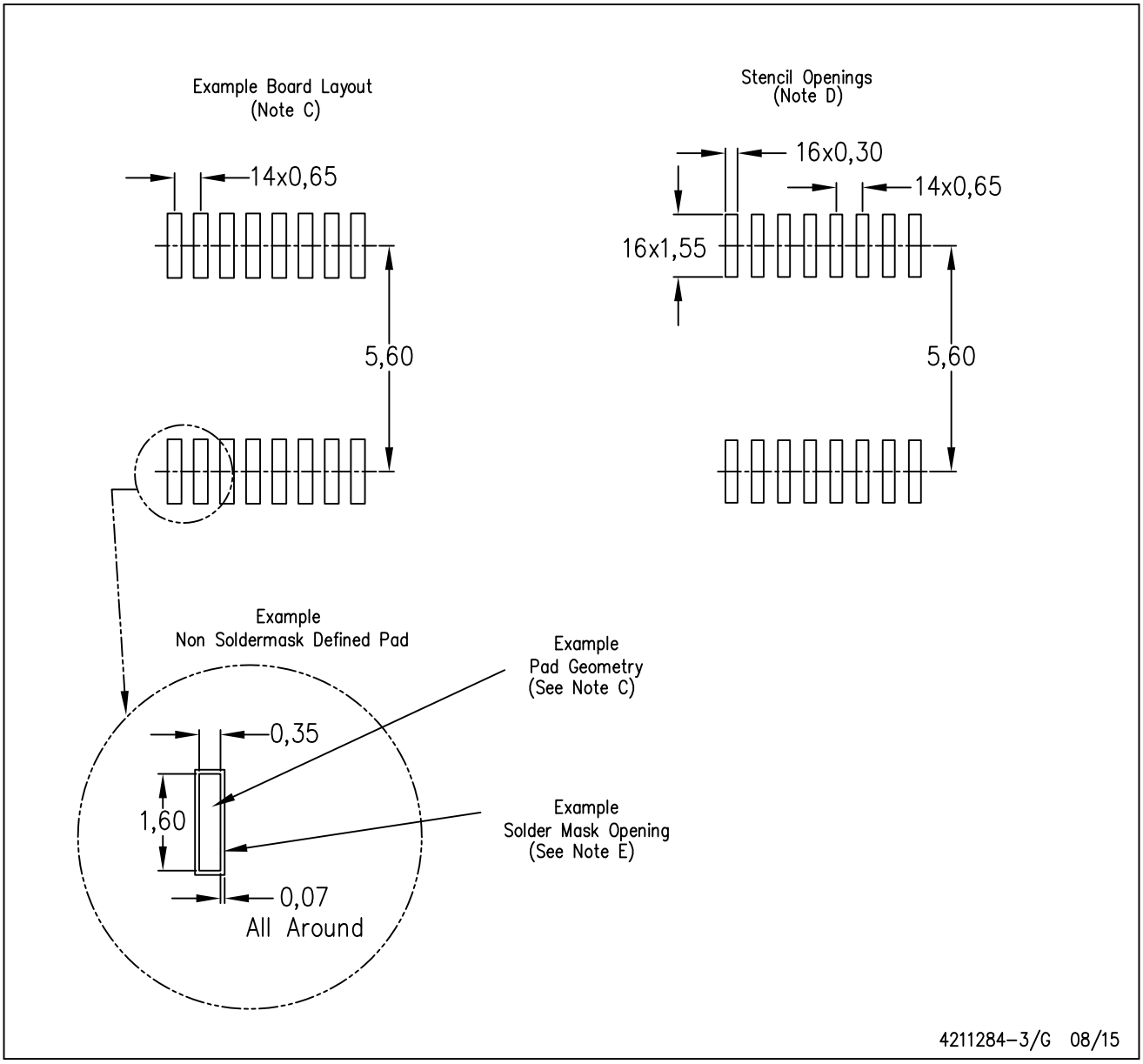
PW (R–PDSO–G16) PLASTIC SMALL OUTLINE



4040064–4/G 02/11

NOTES:
A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M–1994.
B. This drawing is subject to change without notice.
C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
E. Falls within JEDEC MO–153

PW (R–PDSO–G16) PLASTIC SMALL OUTLINE

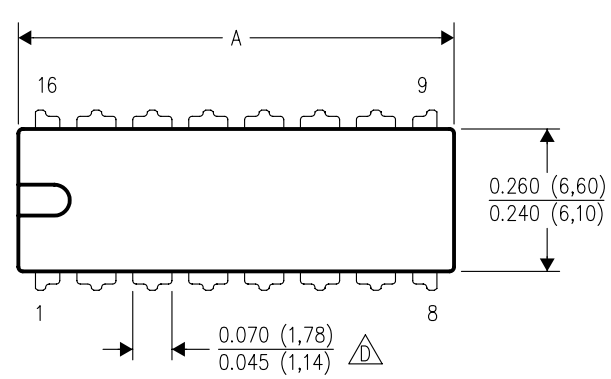


NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Publication IPC–7351 is recommended for alternate designs.
D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC–7525 for other stencil recommendations.
E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

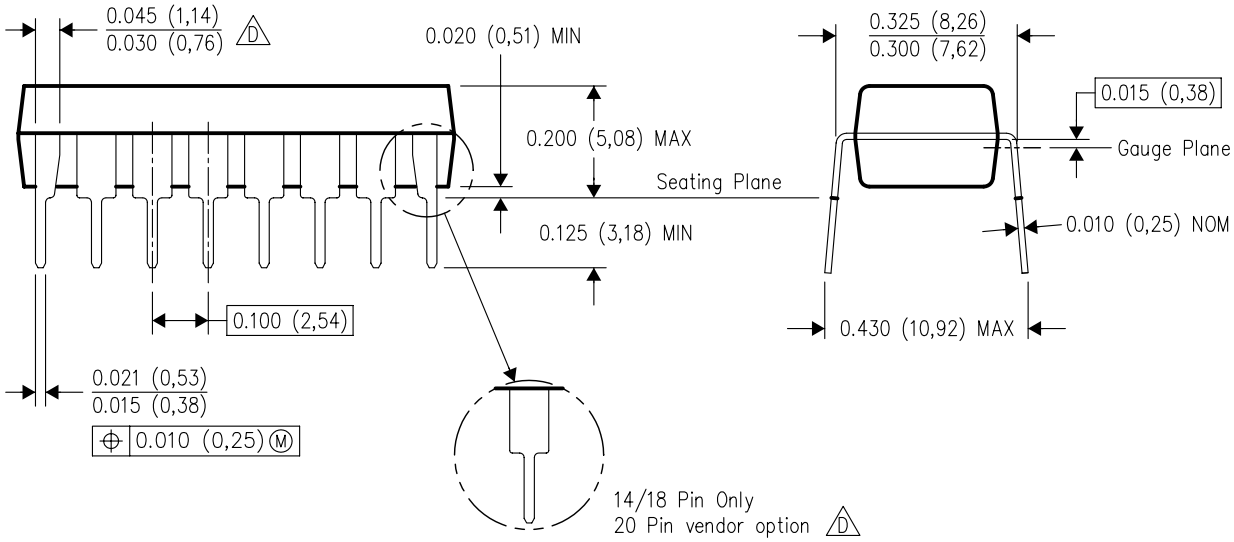
N (R–PDIP–T**)

PLASTIC DUAL–IN–LINE PACKAGE

16 PINS SHOWN



DIM \ PINS **	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS–001 VARIATION (C)	AA	BB	AC	AD



4040049/E 12/2002

NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Falls within JEDEC MS–001, except 18 and 20 pin minimum body length (Dim A).
D. The 20 pin end lead shoulder width is a vendor option, either half or full width.

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